# This Page Is Inserted by IFW Operations and is not a part of the Official Record

# **BEST AVAILABLE IMAGES**

Defective images within this document are accurate representations of the original documents submitted by the applicant.

Defects in the images may include (but are not limited to):

- BLACK BORDERS
- TEXT CUT OFF AT TOP, BOTTOM OR SIDES
- FADED TEXT
- ILLEGIBLE TEXT
- SKEWED/SLANTED IMAGES
- COLORED PHOTOS
- BLACK OR VERY BLACK AND WHITE DARK PHOTOS
- GRAY SCALE DOCUMENTS

# IMAGES ARE BEST AVAILABLE COPY.

As rescanning documents will not correct images, please do not report the images to the Image Problem Mailbox.

# PATENT ABSTRACTS OF JAPAN

(11)Publication number:

61-124574

(43)Date of publication of application: 12.06.1986

(51)Int.CI.

C23C 16/26

(21)Application number: 59-244895

(71)Applicant: HITACHI CHEM CO LTD

(22)Date of filing:

20.11.1984

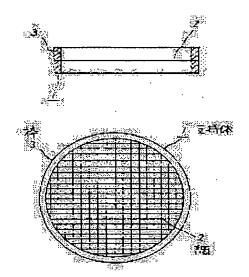
(72)Inventor: AIBA YASUHIRO

HIRAI KEIZO

# (54) CHEMICAL VAPOR DEPOSITION METHOD

(57)Abstract:

PURPOSE: To enable chemical vapor deposition without leaving a support mark by placing a substrate to be subjected to the vapor deposition on the support having the net of carbon fibers coated with thermally decomposable carbon or silicon carbide. CONSTITUTION: The net 2 of carbon fibers is fixed by holding between two frames 3 of artificial graphite, and the net 2 is coated with thermally decomposable carbon or silicon carbide to obtain a support 1. The substrate to be subjected to the vapor deposition is placed on the support 1, and the chemical vapor deposition is carried out. The substrate contacts linearly with the carbon fibers, and a reactive gas penetrates between the substrate and the support 1



because of the finely uneven surfaces of the carbon fibers, so the vapor deposition is carried out on the whole surface of the substrate without leaving the support mark.

# LEGAL STATUS

[Date of request for examination]

[Date of sending the examiner's decision of rejection]

[Kind of final disposal of application other than the examiner's decision of rejection or application converted registration]

[Date of final disposal for application]

http://www1.ipdl.jpo.go.jp/PA1/result/detail/main/wAAAa25613DA361... 2002/11/05

[Patent number]

[Date of registration]

[Number of appeal against examiner's decision of rejection]

[Date of requesting appeal against examiner's decision of rejection]

[Date of extinction of right]

Copyright (C); 1998,2000 Japan Patent Office

### ⑲ 日本国特許庁(JP)

① 特許出願公開

# ⑫ 公 開 特 許 公 報 (A) 阳

昭61 - 124574

@Int\_Cl.4

識別記号

庁内整理番号

匈公開 昭和61年(1986)6月12日

C 23 C 16/26

8218-4K

審査請求 未請求 発明の数 1 (全3頁)

**公発明の名称** 化学蒸着法

②特 願 昭59-244895

**20出 頭 昭59(1984)11月20日** 

康 博

日立市東町 4 丁目13番 1 号 日立化成工業株式会社茨城研

究所内

⑩発明者 平井 圭三

日立市東町 4 丁目13番 1 号 日立化成工業株式会社茨城研

東京都新宿区西新宿2丁目1番1号

究所内

⑪出 願 人 日立化成工業株式会社

r ≠=

砂代 理 人 弁理士 若林 邦彦

1. 発明の名称

化学蒸磨法

- 2. 特許請求の範囲
- 熱分解炭素又は炭化珪素を被覆した炭素線 維の網からなる支持体の上に被蒸剤基材を軟置し て化学蒸着を行なりことを特徴とする化学蒸着法。
- 3. 発明の詳細な説明

(産業上の利用分野)

本発明は基材表面に効率的に化学蒸着を行なり為の方法に関する。

(従来技術)

従来基材 表面に化学 蒸着を行なり方法として、 支持体は、高温では主に人造 風鉛を用い、円錐形 状の頂点で点接触状態で支持する方法が使用され ている。しかしこの方法では基材と支持体とが接 する部分には蒸着膜(被膜)が形成されず跡が残 る為、裏返すか又は支持位置をずらすかして、2 回の蒸着を要する欠点があつた。

(発明の目的)

本発明は、上記欠点を解消し、支持跡の付かない化学蒸着法を提供することを目的とする。

発明者等は研究を重ねた結果、熱分解設案又は 炭化珪素で被覆した炭素繊維の網を使用すること により、蒸着される基材の炭素繊維と扱する部分 に跡が付かず、基材全面に化学蒸着を施こすこと ができることを見出し本発明を完成するに至つた。

(発明の構成)

本発明は、熱分解炭素又は炭化珪素を被覆した 炭素根維の網からなる支持体の上に被蒸着基材を 載置して化学蒸着を行なりことを特徴とする化学 蒸着法に関する。

本発明に用いる炭素線維は、原料、熱処理温度 に関係なくあらゆるものが使用可能である。網への熱分解炭素又は炭化珪素の被覆は公知の蒸着法 による。熱分解炭素又は炭化珪素の被覆する原料 に制限はないが、熱分解炭素の場合はメタン、ブロバン等のデオンデ炭化水素、ベンゼン、トルエン等の芳香族炭化水素、ジクロロエチレン、トリクロロエタン等の有根塩素化合物など、炭化珪素

2

の場合は例えばメチルクロロンラン、珪素原として四塩化珪素、トリクロロンラン等、炭素原として四塩化炭素、トルエン等が好ましい。 蒸磨温度は原料の種類によるが通常 600~2200℃である。 基材に化学減磨を行なりには、支持体の上に基材を報置し公知の方法により行なり。 蒸溜する際の圧力はできるだけ低い方がよいが、同時に蒸磨速度も低下するので数 mmHg付近にすれば支持体と接する部分にも十分に蒸磨できて好ましい。(作用)

上配熱分解炭素又は炭化珪素を被獲した支持体の上に被蒸着基材を載置して化学蒸着を行なり場合、支持体の炭素機維と基材とは憩接触となり、しかも支持体の最面の微細を凹凸により支持体と基材との間にも反応ガスが浸入して基材全面に蒸着被膜が形成され、支持体に関か解皮素又に皮化珪素が被覆されているから化学蒸着後の基材と支持体は固着せず容易にはがれる。

(実施例)

以下に実施例を説明する。

面図に示すよりな高さ10㎜の円錐状突起5を50㎜を×10mの円板部6の中心から120°Cとに等距離の位置に設けた支持体4を作成した。

上記実施例及び比較例の支持体の上に、外径 30m及び厚さ5mmの人造無鉛円盤の基材を戦能 して、実施例1及び実施例2と同じ条件で熱分解 炭素及び炭化珪素を蒸着する実験を行なつた結果 を第1表に示した。

#### 実施例1

高級故跡球加熱炉の水や式石英管(内径100m)の中に、第1図(a)の平面図及び(b)の側面図に示すように炭素繊維の網(東レ株式会社袋、商品名トレカT300)2を外径50mm、内径40mm、厚さ5mmの二つの人造無鉛の枠3で挟んで固定した支持体1を入れ、1mmHgの波圧状態で1800℃に加熱し、ブロパン20容量を含む窒素ガスを大気圧の流量で毎分3ℓずつ1時間流し、支持体に熱分解炭素を蒸着被覆した。熱分解炭素の膜厚は40μmであつた。

#### 実施例2

第1図に示す支持体1を実施例1と同様にして
1 mmHgの放圧状態で1400℃に加熱し、四塩
×10<sup>-4</sup>
化珪素9~モル/分、トルエン3~モル/分及び水素
ガスを大気圧の流量で3ℓ/分の割合で1時間流
し、支持体に炭化珪素を蒸着被覆した。炭化珪素
の膜厚は60μm であつた。

#### 比較例

人造黒鉛材を加工し第2図(a)の平面図、(b)の側

	(文)	#	د	段化ケイ素	шт 0 9	(柳园)0
	±3	人	*	熱分解炭素	4 0 mm	(暴圍)0
<b>-</b> -	英施例2	<b>汉素廢益</b>	炭化硅紫	炭化硅紫	ш#09	ш#0S
张	吳施例1	员架锹縒	熱分解炭素	熱分解歧案	w r 0 þ	ш и ў Е
	支持体の電類	支持体の材料	支持体被膜	基材への蒸溜被膜	番材 上面の 被原厚さ	支持部分の被膜厚さ

# 特開昭 61-124574 (3)

第1 表から明らかなよりに、比較例の支持体を 用いた場合は基材の支持部分に蒸磨されず基材と 支持体が固磨したのに対し、実施例の場合は支持 部分の被膜厚さは他の部分より若干薄い程度であ り、基材と支持体が固磨することはなかつた。

上記実験では1回の蒸着で基材1枚であつたが 小さい基材ならば、又は大きい加熱炉及び支持体 を使えば多量の基材の蒸着処理が可能である。

#### (発明の効果)

本発明によれば、基材が支持体に固着することがなく、1回の作業で基材全面に蒸着被膜を形成することができ、効率的な化学蒸着が可能となる。
4. 図面の簡単な説明

第1図は,本発明の実施例になる支持体で(a)は 平面図,(b)は側面図,第2図は比較例の支持体で (a)は平面図,(b)は側面図である。

#### 符号の説明

1…支持体

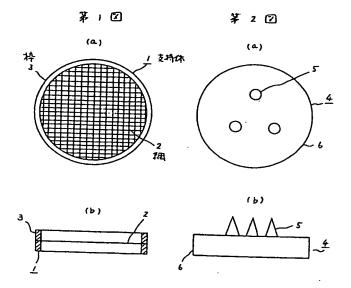
2 …網

3 …枠

4 …支持体

5 … 円錐状突起

6 … 円板部



- (19) Japan Patent Office (JP)
- (12) Gazette of Unexamined Patent Application (A)
- (11) Patent Application Laid-Open (KOKAI) S61-124574
- (51) Int.Cl.4 ID Symbol Internal Reference No.
- 5 C 23 C 16/26 8218-4K
  - (43) Publication (KOKAI) Date: June 12, 1986

Request for Examination: Not requested

Number of Inventions: 1 (3 pages in total)

- 10 (54) Title of the Invention: Chemical Evaporation Method
  - (21) Application No. S59-244895
  - (22) Filing Date: November 20, 1984
  - (72) Inventor: Yasuhiro AIBA

Hitachi Chemical Co., Ltd., Ibaraghi

15 Research Laboratory

13-1, Higashicho 4-chome, Hitachi-shi

(72) Inventor: Keizo HIRAI

Hitachi Chemical Co., Ltd., Ibaraghi

Research Laboratory

- 20 13-1, Higashicho 4-chome, Hitachi-shi
  - (71) Applicant: Hitachi Chemical Co., Ltd. 1-1, Nishi-shinjuku 2-chome, Shinjuku-ku,

Tokyo

(74) Attorney: Kunihiko WAKABAYASHI, Patent Attorney

25

#### Specification

#### 1. Title of the Invention

# CHEMICAL EVAPORATION METHOD

#### 2. Claims

- 1. A chemical evaporation method characterized in that a substrate that is to be subjected to evaporation is placed on a support made of a mesh of carbon fibers covered with pyrolyzed carbon or silicon carbide, after which chemical evaporation is performed.
  - 3. Detailed Description of the Invention

# (Field of Industrial Utilization)

The present invention relates to a method for performing chemical evaporation in an efficient manner on the surface of a substrate.

#### (Prior Art)

15

20

25

A method in which mainly artificial graphite is used as a support at high temperatures, and support is provided in a state of point contact at the apex of a circular conical shape, has been used in the past as a method for performing chemical evaporation. However, such a method suffers from the following drawback: namely, no evaporation film (coating) is formed in the areas where the substrate and support contact each other, so that marks remain; accordingly, evaporation must be performed a second time after the substrate is turned upside down or after the supporting position is shifted.

#### (Object of the Invention)

It is an object of the present invention to climinate the abovementioned drawback, and to provide a chemical evaporation method that leaves no support marks.

As a result of extensive research, the present inventors discovered that by

5

10

15

20

25

using a mesh made of carbon fibers covered with pyrolyzed carbon or silicon carbide [as a support], it is possible to perform chemical evaporation over the entire surface of a substrate without leaving marks in the areas where the substrate on which evaporation is performed contacts the carbon fibers. This discovery led to the perfection of the present invention.

# (Constitution of the Invention)

The present invention relates to a chemical evaporation method which is characterized in that a substrate that is to be subjected to evaporation is placed on a support consisting of a mesh of carbon fibers covered with pyrolyzed carbon or silicon carbide, after which chemical evaporation is performed.

All types of carbon fibers, regardless of the raw material or heat treatment temperature used, may be used as the carbon fibers of the present invention. The coating of the mesh with pyrolyzed carbon or silicon carbide is accomplished by a universally known evaporation process. There are no restrictions on the raw materials used for this coating with pyrolyzed carbon or silicon carbide. However, in the case of pyrolyzed carbon, it is desirable to use an aliphatic hydrocarbon such as methane, propane or the like, an aromatic hydrocarbon such as benzene toluene or the like, or an organo-chlorine compound such as dichloroethylene, trichloroethane or the like, [as the raw material], and in the case of silicon carbide, it is desirable to use (for example) methylchlorosilane, or to use silicon tetrachloride, trichlorosilane or the like as a silicon source, and to use carbon tetrachloride, toluene or the like as a carbon source. The evaporation temperature depends on the types of raw materials used, but is ordinarily 600 to 2200°C. In order to perform chemical evaporation, the substrate is placed on the support, and chemical evaporation is performed by a universally known method It is desirable that the pressure during evaporation be as low as possible. At the

same time, however, the evaporation rate drops: accordingly, if the pressure is set in the vicinity of several mmHg, evaporation can also be sufficiently performed in the areas contacting the support, so that such a pressure is desirable. (Effect)

5

10

15

20

25

In cases where chemical evaporation is performed with the substrate that is being subjected to evaporation placed on the abovementioned support covered with pyrolyzed carbon or silicon carbide, the carbon fibers of the support and the substrate are in linear contact, and the reaction gas also enters the spaces between the support and the substrate as a result of the fine indentations and projections on the surface of the support, so that a evaporation film is formed over the entire surface of the substrate. Furthermore, since the support is covered with pyrolyzed carbon or silicon carbide, the substrate following chemical evaporation and the support do not adhere to each other, and can easily be separated.

#### (Examples)

Examples will be described below.

#### Example 1

A support I in which a carbon fiber mesh (manufactured by Toray K.K., commercial name Torayka T300) 2 was clamped and fastened between two artificial graphite frames 3 with an external diameter of 50 mm. an internal diameter of 40 mm and a thickness of 5 mm as shown in a plan view in Fig. 1 (a) and a side view in Fig. 1 (b) was placed inside a heating furnace (internal diameter 100 mm), and was heated to 1800°C under a reduced pressure of 1 mmHg. Nitrogen gas containing 20 vol % propane was caused to flow through for 1 hour at the rate of 3 liters/min (flow rate at atmospheric pressure), so that the support was covered with pyrolyzed carbon by evaporation. The thickness of the pyrolyzed

5

15

20

carbon film was 40 µm.

Example 2

The support 1 shown in Fig. 1 was heated to  $1400^{\circ}$ C under a reduced pressure of 1 mmHg in the same manner as in Example 1: then, for 1 hour, carbon tetrachloride was caused to flow through at the rate of  $9 \times 10^{-4}$  mol/min, toluene was caused to flow through at the rate of  $3 \times 10^{-4}$  mol/min, and hydrogen gas was caused to flow through at the rate of 3 liters/min (flow rate at atmospheric pressure), so that the support was coated with silicon carbide by evaporation. The thickness of the silicon carbide film was  $60 \ \mu m$ .

# 10 Comparative Example

A support 4 was prepared by working an artificial graphite material so that circular conical projections 5 with a height of 10 mm (as shown in a plan view in Fig. 2 (a) and a side view in Fig. 2 (b)) were formed at intervals of 120° in positions equidistant from the center of a disk part with a diameter of 50 mm and a thickness of 10 mm.

An experiment was performed in which substrates each consisting of a disk of artificial graphite with an external diameter of 30 mm and a thickness of 5 mm were placed on the supports of the abovementioned examples and comparative example, and were coated with pyrolyzed carbon and silicon carbide under the same conditions as in Example 1 and Example 2. The results obtained are shown in Table 1.

5

10

15

Table 1

Type of support	Example I	Example 2	Comparative Example	
Material of support	Carbon fibers	Carbon fibers	Artificial graphite	
Support coating film	Pyrolyzed carbon	Silicon carbide	None	
Coating film formed on	Pyrolyzed carbon	Silicon carbide	Pyrolyzed	Silicon
substrate by			carbon	carbide
evaporation				
Thickness of coating	40 µm	60 µm	40 μm	60 µm
film on upper surface of				
substrate	·			
Thickness of coating	35 µm	50 μm	0	0
ilm in supported areas		·	(adhesion)	(adhesion)

As is seen from Table 1, there was no evaporation in the supported areas lof the substratel, and the substrate and support adhered to each other, in cases where the support of the Comparative Example was used. On the other hand, in the case of the Examples, the coating film thickness in the supported areas was merely slightly thinner than in other areas, and there was no adhesion of the substrate and support to each other.

In the above experiments, a single substrate was used in a single evaporation operation. However, if the substrates are small, or if a large heating furnace and support are used, large quantities of substrates can be subjected to a evaporation treatment [at one time].

# (Merits of the Invention)

The present invention makes it possible to form a evaporation coating film over the entire surface of a substrate in a single operation without any

adhesion of the substrate to the support, so that efficient chemical evaporation is possible.

# 4. Brief Description of the Drawings

Fig. 1 shows the support used in the examples of the present invention;

Fig. 1 (a) is a plan view, and Fig. 1 (b) is a side view. Fig. 2 shows the support used in a comparative example; Fig. 2 (a) is a plan view, and Fig. 2 (b) is a side view.

Explanation of Reference Numerals

- 1 Support
- 10 2 Mesh
  - 3 Frames
  - 4 Support
  - 5 Circular conical projections
  - 6 Disk part

15

FIG. 1

- 1 SUPPORT
- 2 MESH
- 3 FRAMES